

$V_{DRM} = 2500 \text{ V}$   
 $I_{TGQM} = 2500 \text{ A}$   
 $I_{TSM} = 16 \text{ kA}$   
 $V_{T0} = 1.66 \text{ V}$   
 $r_T = 0.57 \text{ m}\Omega$   
 $V_{DClin} = 1400 \text{ V}$

# Gate turn-off Thyristor

## 5SGA 25H2501

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- Patented free-floating silicon technology
- Low on-state and switching losses
- Annular gate electrode
- Industry standard housing
- Cosmic radiation withstand rating

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### Blocking

$V_{DRM}$	Repetitive peak off-state voltage	2500 V	$V_{GR} \geq 2V$
$V_{RRM}$	Repetitive peak reverse voltage	17 V	
$I_{DRM}$	Repetitive peak off-state current	$\leq 30 \text{ mA}$	$V_D = V_{DRM}$ $V_{GR} \geq 2V$
$I_{RRM}$	Repetitive peak reverse current	$\leq 50 \text{ mA}$	$V_R = V_{RRM}$ $R_{GK} = \infty$
$V_{DClink}$	Permanent DC voltage for 100 FIT failure rate	1400 V	$-40 \leq T_j \leq 125 \text{ }^\circ\text{C}$ . Ambient cosmic radiation at sea level in open air.

### Mechanical data (see Fig. 19)

$F_m$	Mounting force	min.	17	kN
		max.	24	kN
A	Acceleration: Device unclamped Device clamped		50	$\text{m/s}^2$
			200	$\text{m/s}^2$
M	Weight		0.8	kg
$D_s$	Surface creepage distance	$\geq$	22	mm
$D_a$	Air strike distance	$\geq$	13	mm

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## GTO Data

### On-state

$I_{TAVM}$	Max. average on-state current	830 A	Half sine wave, $T_C = 85^\circ\text{C}$	
$I_{TRMS}$	Max. RMS on-state current	1300 A		
$I_{TSM}$	Max. peak non-repetitive surge current	16 kA	$t_P = 10\text{ ms}$	$T_j = 125^\circ\text{C}$ After surge:
		32 kA	$t_P = 1\text{ ms}$	
$I^2t$	Limiting load integral	$1.28 \cdot 10^6\text{ A}^2\text{s}$	$t_P = 10\text{ ms}$	$V_D = V_R = 0\text{V}$
		$0.51 \cdot 10^6\text{ A}^2\text{s}$	$t_P = 1\text{ ms}$	
$V_T$	On-state voltage	3.10 V	$I_T = 2500\text{ A}$	$T_j = 125^\circ\text{C}$
$V_{T0}$	Threshold voltage	1.66 V	$I_T = 200 - 3000$	
$r_T$	Slope resistance	0.57 mΩ	3000 A	
$I_H$	Holding current	50 A	$T_j = 25^\circ\text{C}$	

### Gate

$V_{GT}$	Gate trigger voltage	1.0 V	$V_D = 24\text{ V}$	$T_j = 25^\circ\text{C}$
$I_{GT}$	Gate trigger current	2.5 A	$R_A = 0.1\text{ W}$	
$V_{GRM}$	Repetitive peak reverse voltage	17 V		
$I_{GRM}$	Repetitive peak reverse current	50 mA	$V_G = V_{GRM}$	

### Turn-on switching

$di/dt_{crit}$	Max. rate of rise of on-state current	400 A/μs	$f = 200\text{Hz}$	$I_T = 2500\text{ A}, T_j = 125^\circ\text{C}$
		700 A/μs	$f = 1\text{Hz}$	$I_{GM} = 30\text{ A}, di_G/dt = 20\text{ A}/\mu\text{s}$
$t_d$	Delay time	1.5 μs	$V_D = 0.5 V_{DRM}$	$T_j = 125^\circ\text{C}$
$t_r$	Rise time	3.5 μs	$I_T = 2500\text{ A}$	$di/dt = 200\text{ A}/\mu\text{s}$
$t_{on(min)}$	Min. on-time	120 μs	$I_{GM} = 30\text{ A}$	$di_G/dt = 20\text{ A}/\mu\text{s}$
$E_{on}$	Turn-on energy per pulse	0.85 Ws	$C_S = 6\text{ }\mu\text{F}$	$R_S = 5\text{ }\Omega$

### Turn-off switching

$I_{TGQM}$	Max controllable turn-off current	2500 A	$V_{DM} = V_{DRM}$	$di_{GQ}/dt = 30\text{ A}/\mu\text{s}$
			$C_S = 6\text{ }\mu\text{F}$	$L_S \leq 0.3\text{ }\mu\text{H}$
$t_s$	Storage time	24.0 μs	$V_D = \frac{1}{2} V_{DRM}$	$V_{DM} = V_{DRM}$
$t_f$	Fall time	2.0 μs	$T_j = 125^\circ\text{C}$	$di_{GQ}/dt = 30\text{ A}/\mu\text{s}$
$t_{off(min)}$	Min. off-time	80 μs	$I_{TGQ} = I_{TGQM}$	
$E_{off}$	Turn-off energy per pulse	3.5 Ws	$C_S = 6\text{ }\mu\text{F}$	$R_S = 5\text{ W}$
$I_{GQM}$	Peak turn-off gate current	700 A	$L_S \leq 0.3\text{ }\mu\text{H}$	

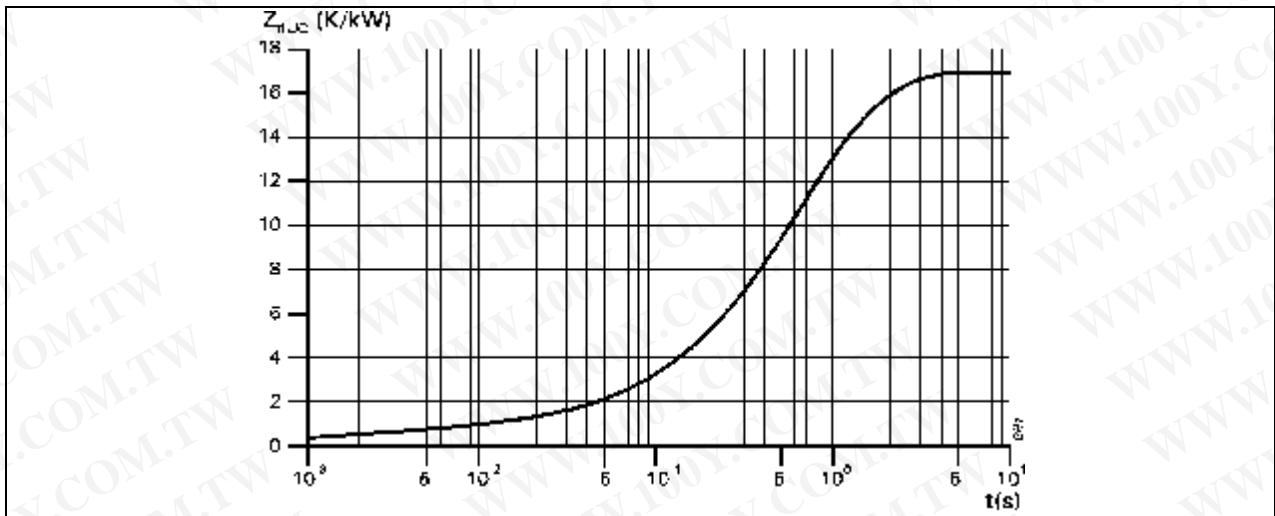
**Thermal**

$T_j$	Storage and operating junction temperature range	-40...125°C	
$R_{thJC}$	Thermal resistance junction to case	30 K/kW	Anode side cooled
		39 K/kW	Cathode side cooled
		17 K/kW	Double side cooled
$R_{thCH}$	Thermal resistance case to heat sink	10 K/kW	Single side cooled
		5 K/kW	Double side cooled

**Analytical function for transient thermal impedance:**

$$Z_{thJC}(t) = \sum_{i=1}^4 R_i(1 - e^{-t/t_i})$$

i	1	2	3	4
$R_i$ (K/kW)	11.7	4.7	0.64	0.0001
$\tau_i$ (s)	0.9	0.26	0.002	0.001



**Fig. 1** Transient thermal impedance, junction to case.

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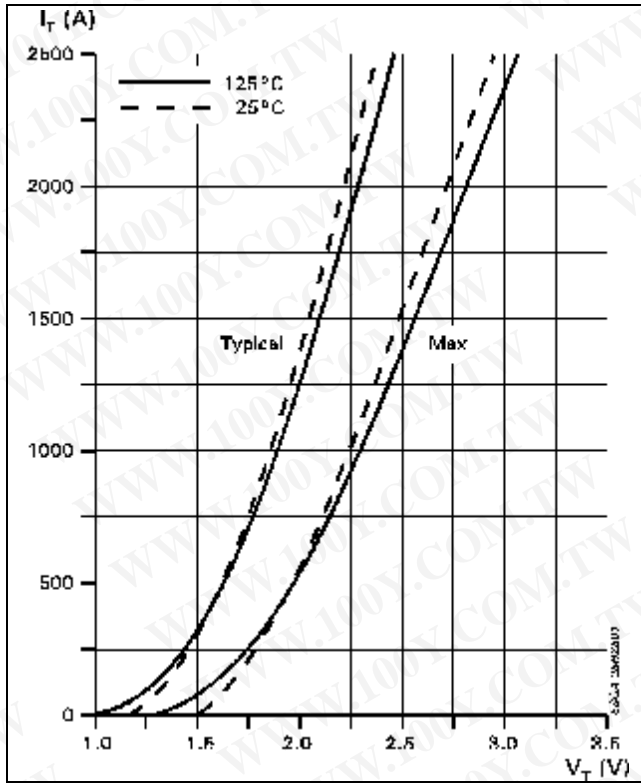


Fig. 2 On-state characteristics

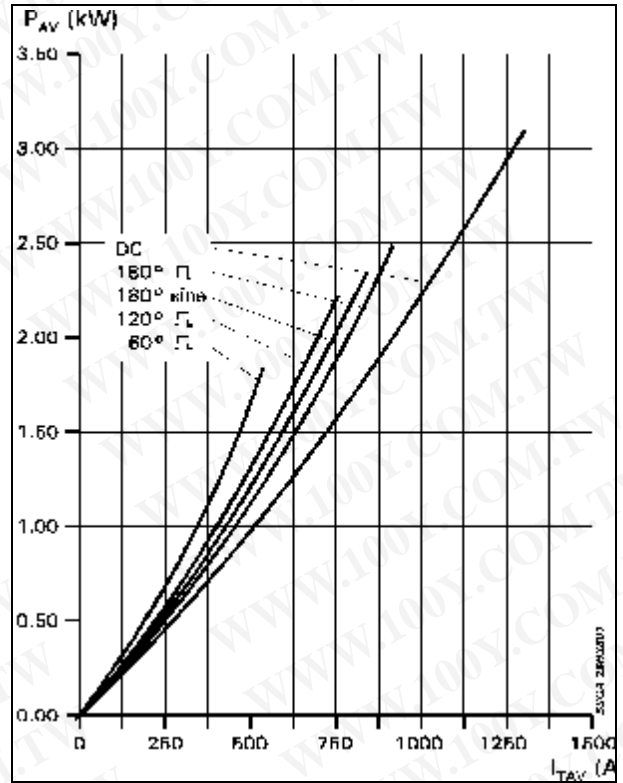


Fig. 3 Average on-state power dissipation vs. average on-state current.

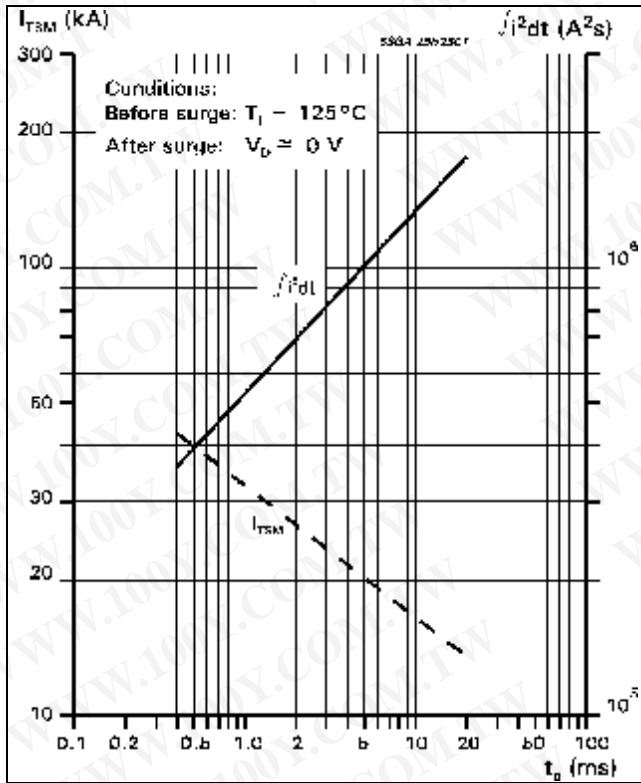


Fig. 4 Surge current and fusing integral vs. pulse width

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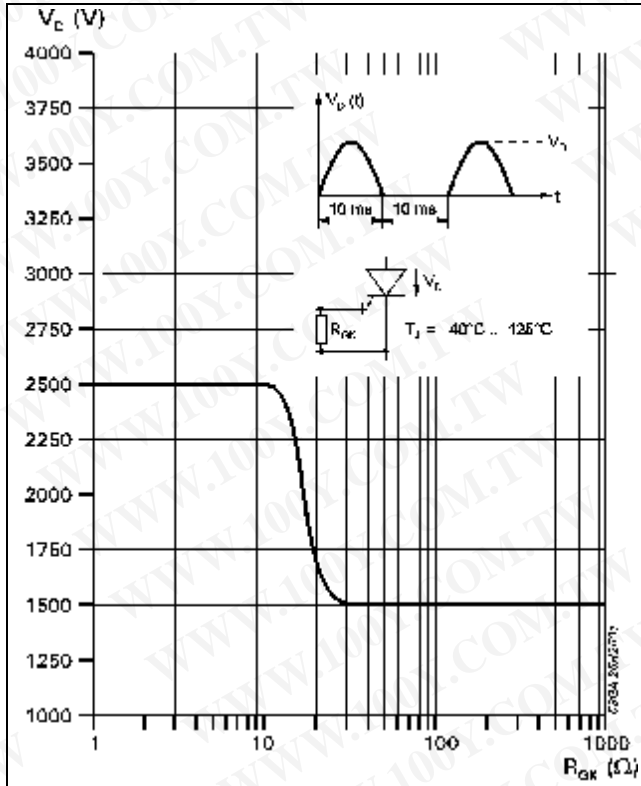


Fig. 5 Forward blocking voltage vs. gate-cathode resistance.

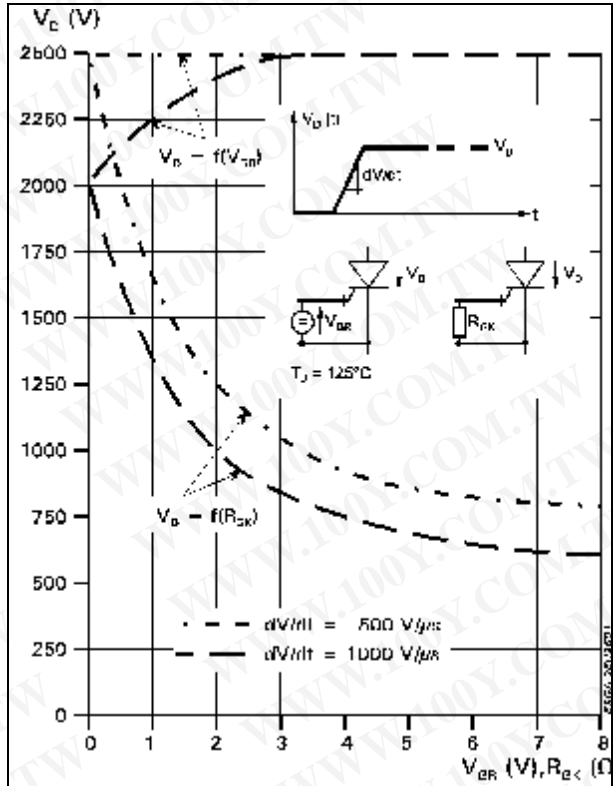


Fig. 6 Static dv/dt capability: Forward blocking voltage vs. neg. gate voltage or gate cathode resistance.

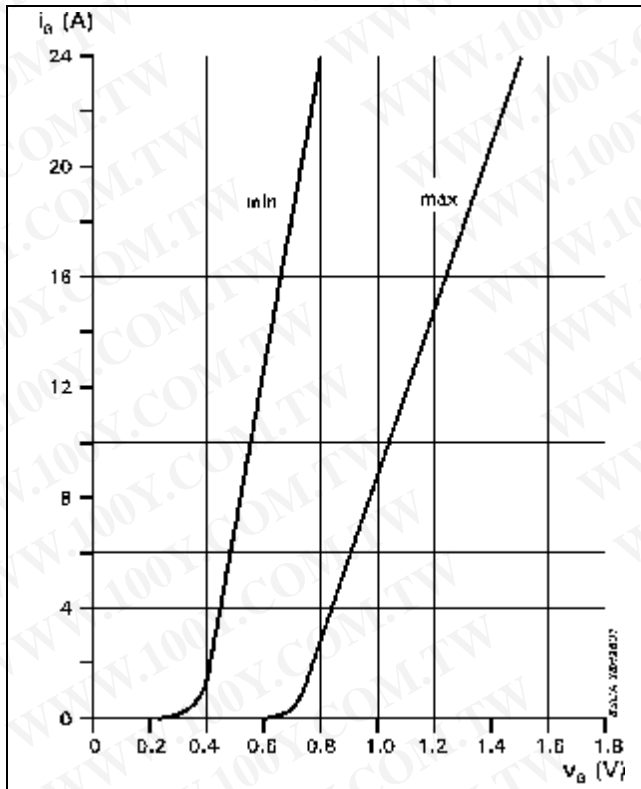


Fig. 7 Forward gate current vs. forward gate voltage.

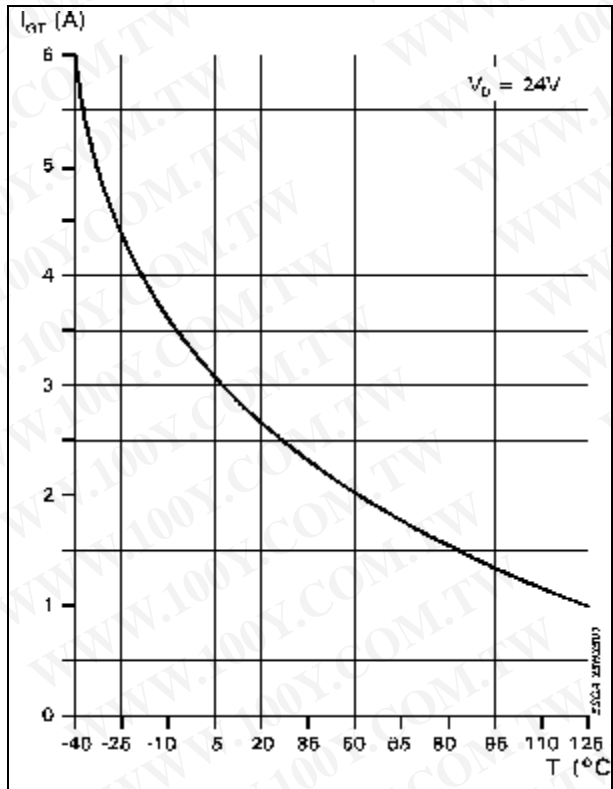


Fig. 8 Gate trigger current vs. junction temperature

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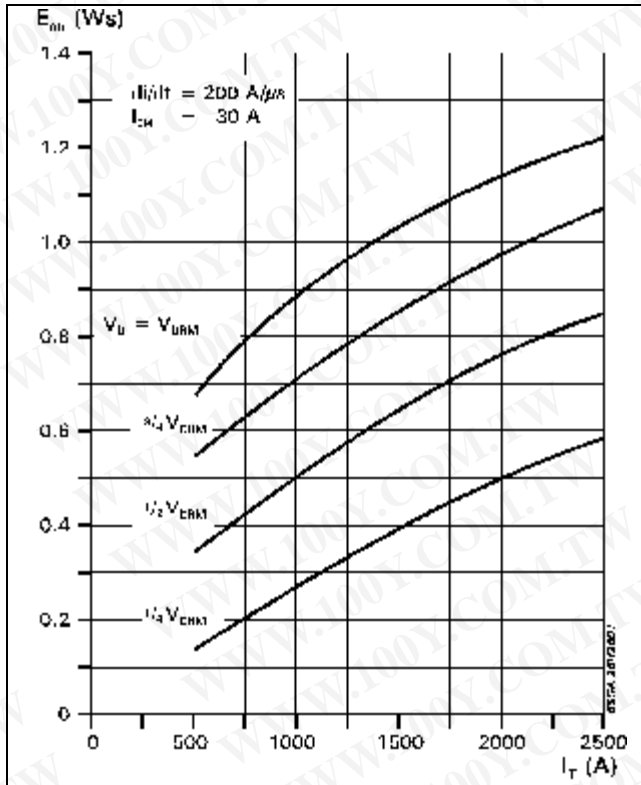


Fig. 9 Turn-on energy per pulse vs. on-state current and turn-on voltage.

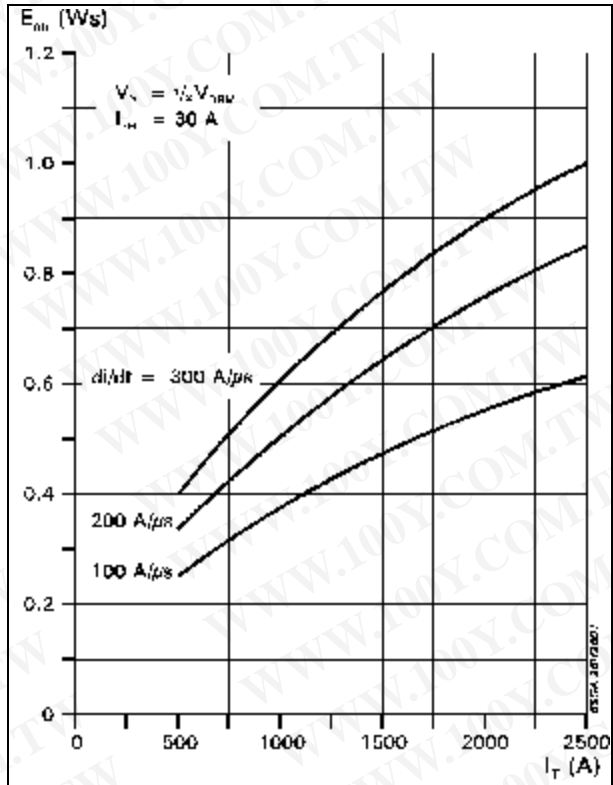


Fig. 10 Turn-on energy per pulse vs. on-state current and current rise rate

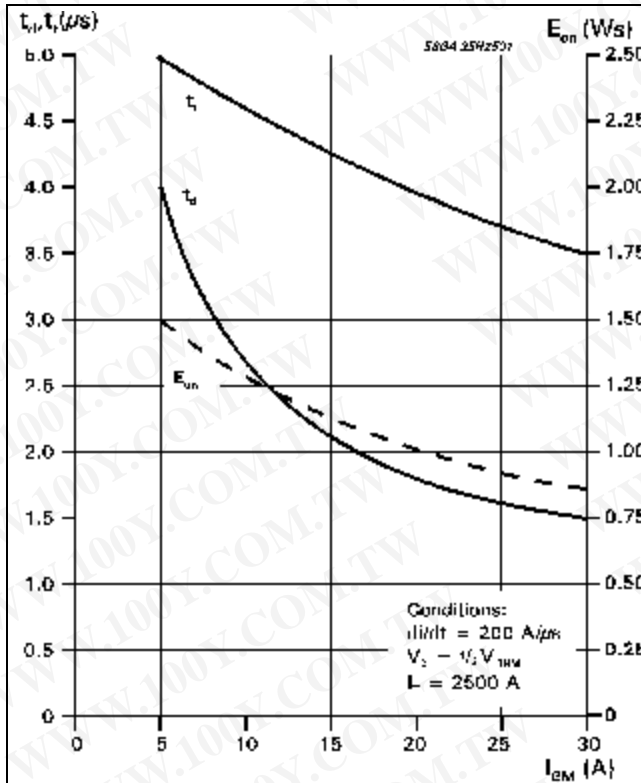


Fig. 11 Turn-on energy per pulse vs. on-state current and turn-on voltage.

Common Test conditions for figures 9, 10 and 11:

- $di_G/dt = 20 \text{ A}/\mu\text{s}$
- $C_S = 6 \mu\text{F}$
- $R_S = 5 \Omega$
- $T_J = 125 \text{ }^\circ\text{C}$

Definition of Turn-on energy:

$$E_{on} = \int_0^{20 \text{ ms}} V_D \cdot I_T dt \quad (t = 0, I_G = 0.1 \cdot I_{GM})$$

Common Test conditions for figures 12, 13 and 15:

Definition of Turn-off energy:

$$E_{off} = \int_0^{40 \text{ ms}} V_D \cdot I_T dt \quad (t = 0, I_T = 0.9 \cdot I_{TGO})$$

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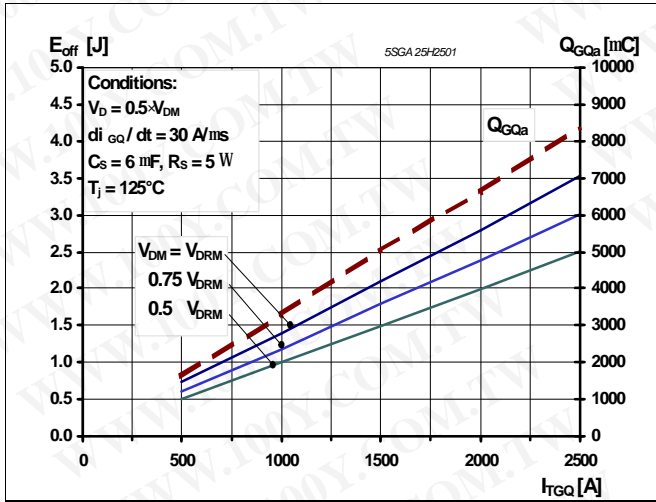


Fig. 12 Turn-off energy per pulse vs. turn-off current and peak turn-off voltage. Extracted gate charge vs. turn-off current.

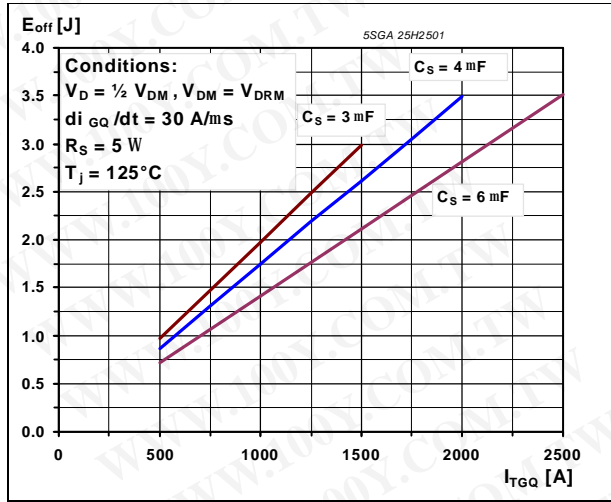


Fig. 13 Turn-off energy per pulse vs. turn-off current and snubber capacitance.

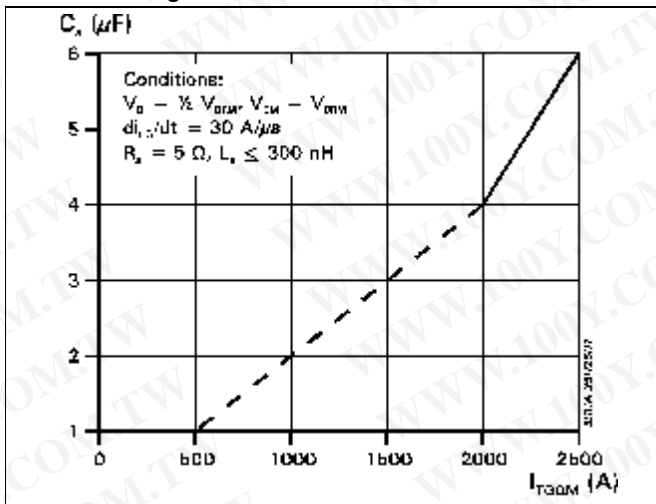


Fig. 14 Required snubber capacitor vs. max allowable turn-off current.

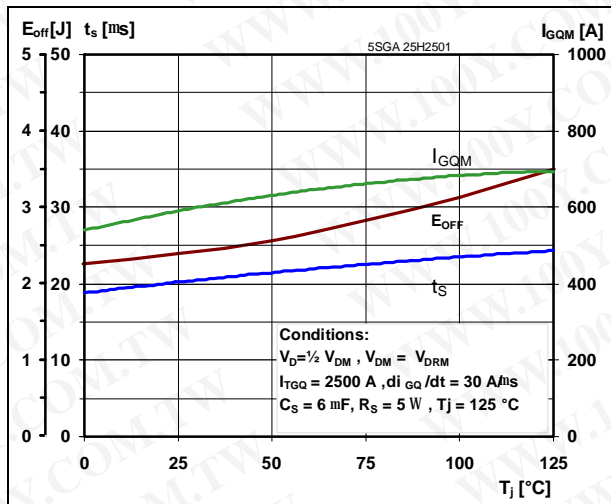


Fig. 15 Turn-off energy per pulse, storage time and peak turn-off gate current vs. junction temperature

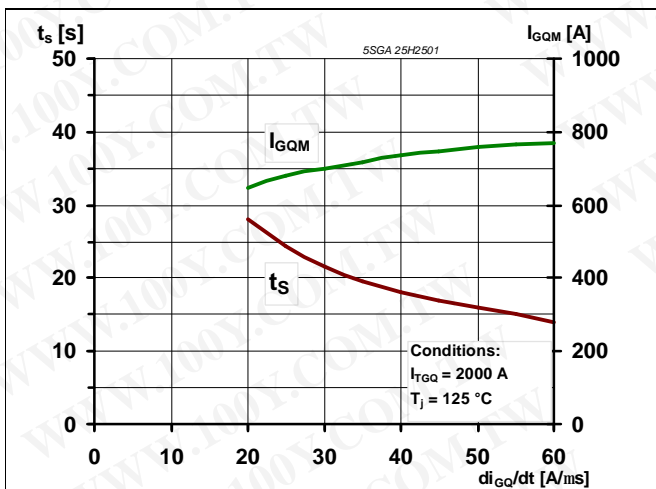


Fig. 16 Storage time and peak turn-off gate current vs. neg. gate current rise rate.

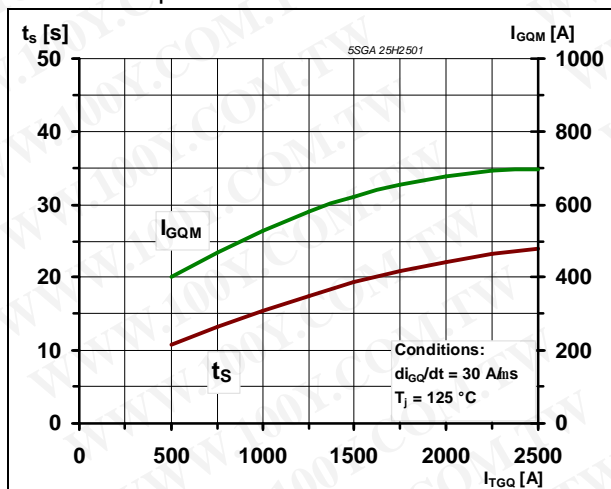


Fig. 17 Storage time and peak turn-off gate current vs. turn-off current

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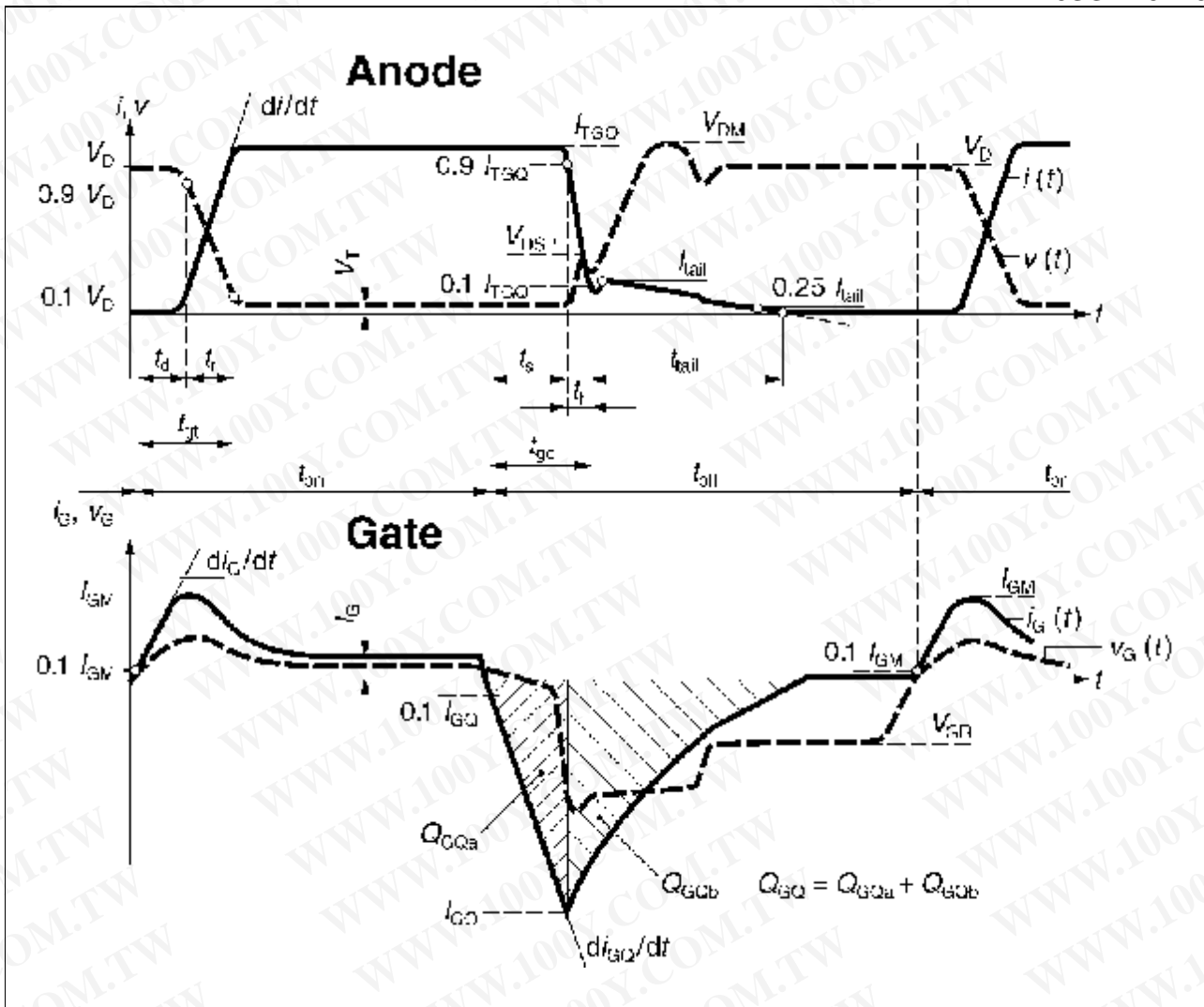


Fig. 18 General current and voltage waveforms with GTO-specific symbols

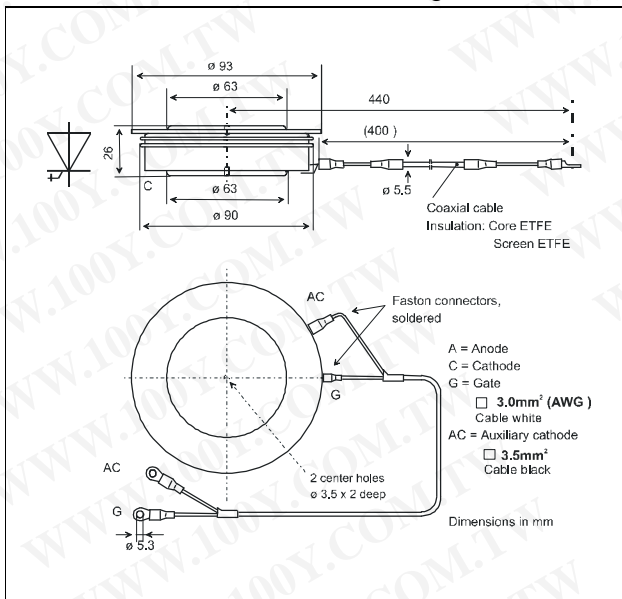


Fig. 19 Outline drawing. All dimensions are in millimeters and represent nominal values unless stated otherwise.

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**Reverse avalanche capability**

In operation with an antiparallel freewheeling diode, the GTO reverse voltage  $V_R$  may exceed the rate value  $V_{RRM}$  due to stray inductance and diode turn-on voltage spike at high  $di/dt$ . The GTO is then driven into reverse avalanche. This condition is not dangerous for the GTO provided avalanche time and current are below 10  $\mu$ s and 1000 A respectively. However, gate voltage must remain negative during this time. Recommendation :  $V_{GR} = 10... 15$  V.

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